

10/542611

104 00047510 18 JUL 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Inventors: Kenichiro SHINOI, et al.

Application No.: New PCT National Stage Application

Filed: July 18, 2005

For: ACCURACY MEASUREMENT APPARATUS AND ACCURACY
MEASUREMENT METHOD FOR CHANNEL QUALITY REPORT

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner of Patents
Washington, DC 20231

Dear Sir:

Pursuant to Rules 56 and 99, Applicants hereby call the attention of the Patent Office to the art listed on the attached Form PTO 1449. Copies of the art cited in the International Search Report (ISR), which issued by the JPO, are made available to the U.S. examiner in the national stage application, pursuant to MPEP 1893.03(g), and therefore copies of such art are not submitted herewith. The art cited in the ISR is listed on the attached PTO-1449 for an indication of consideration by the examiner. Copies of any other references listed on the PTO-1449, besides those cited in the ISR, are submitted herewith. The 3GPP R4-021533 document is discussed in the present application at page 2, line 13 et seq. US '827 corresponds to JP '040.

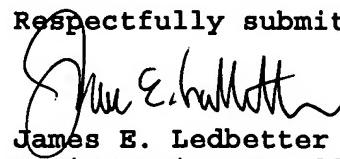
Applicants present this art so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see Beckman Instruments, Inc. v. Chemtronics, Inc., 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir. 1970). Also see Patent Office Rules 104 and 106.

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JC14 Rec'd PCT/PTO 18 JUL 2005

Applicants respectfully request that this art be expressly considered during the prosecution of this application and made of record herein and appear among the "References Cited" on any patent to issue herefrom.

Respectfully submitted,


James E. Ledbetter
Registration No. 28,732

Date: July 18, 2005

JEL/spp

ATTORNEY DOCKET NO. L9289.05161

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FORM PTO-1449 U.S. Department of Commerce
(Rev. 4/92) Patent and Trademark Office

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

ATTY. DOCKET NO

L9289.05161

SERIAL NO. 0754

New PCT Nat'l Stage Application

APPLICANT

Kenichiro SHINOI, et al.

FILING DATE

DATE
July 18, 2005

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

PCT International Search Report dated Feb. 3, 2004.

"VRC Test Approach," TSG-RAN Working Group 4 (Radio) meeting #25, Secaucus, New Jersey, USA, 11th-15th November 2002, R4-021533, 1 page front & back.

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to applicant.